





# **JMQWG Mission Statement**

Perform a common set of IUID direct 2D mark qualification, and output of subsequent report data for the following 3 criteria, that most of the DoD supplier base can use with little or no further effort required:
(1) IUID Marking Methods (dot peen, laser/chem etch, direct ink, label, etc)
(2) Material Types & Finishes (80% common to most of Industry)
(3) Environmental Criteria (80% common to most of Industry or use worst case)
Goal is to capitalize on a "consortium approach" and use Qual data sharing to the maximum extent possible. This is not considered a competitive advantage item, since all DoD suppliers must comply with the IUID initiative.



# **JMQWG** Communications



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### PRESS RELEASE

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#### GEIA-SPONSORED WORKING GROUP MAKING NOTEWORTHY PROGRESS

Arlington, VA – The Joint Marking Qualification Working Group (JMQWG), established in July 2005 and sponsored by the Government Electronics Information Technology Association (GEIA), announced that it is making noteworthy progress in achieving its goals. The Group's objective is to provide valuable guidance on appropriate 2D marking methods for an 80% common solution set of standard material types and environments, to meet the Department of Defense's <u>Unique (Dentification (UD)</u>) initiative. The backbone of the guidance is a comprehensive Marking Matrix backed-up by real world qualification test data for various marking scenarios. Proving the 'jointees' of this activity, the GELA's JMQWG Matrix is being prepared and populated by the University of Alabama – Huntsville, under functing from the DoD Office of Material Readiness & Sustainment Policies. This data enables companies to streamline and reduce material Representing gualification activities and allow design engineering to quickly focus on an optimum marking solution. Decision trees and other helpful guidance tools are also provided to aid both first time and experienced personnel sort through the realm of marking options and parameters.

The Working Group consists of Industry, Academia and Government personnel who have made "significant progress in creating a collaborative environment for sharing this specialized technical data that can help a large segment of companies doing business with the DoD" said Mitch Kaarlela, one of the Industry leaders of the Working Group. Approximately 20 high-level test summaries have been posted date, backed-up by over 80 detailed test reports. Additional 2D mark qualification test data is scheduled to be completed in the coming months and will be posted on the collaboration website being hosted by the Defense Acquisition University (DAU) and their Acquisition Community Connection.

To view the Working Group's technical data and the results achieved to-date, please logon to the DAU's ACC webpage at: <u>https://acc.dau.mil/simplify/ev.php?ID=34767\_201&ID2=DO\_TOPIC</u>

To become involved in the Working Group, or to share existing UID marking qualification data, or to simply ask a working group-related question, please contact one of the following:

Mitch Kaarlela (Lockheed Martin) 817-935-3488 Chris Sautter (Univ Ala – Huntsville) 256-824-6147 Rob Leibrandt (DoD UID Office) 703-695-1099 mitchell.l.kaarlela@lmco.com chris.sautter@uah.edu robert.leibrandt@osd.mil

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About the Government Electronics and Information Technology Association (GEIA) GEIA is a trade association representing the "high-tech" industry doing business with government. Our member companies are active in serving the electronics- and information technology-related needs of government customers. We connect industry to government through a unique forecasting process, conducting hundreds of customer interviews in which our companies directly participate. We analyze and issue reports on the federal market for IT solutions, technologies, and advanced electronics products and services of all kinds, producing: An annual 10-Year Defense Forecast; an annual 5-year Federal IT Forecast; and special market studies of the government market such as Services & Support, Homeland Security, etc. Details on GEIA may be found at <u>http://www.geia.org/</u> GEIA Sponsorship Achieved, <u>Communications Successful</u> ✓ Updated Press Release of Progress ✓ DAU Website – Test Data Vaulted ✓ Many Contributor Companies

Honeywell
Raytheon
Lockheed Martin
Boeing
Rolls Royce
Bell Helicopter
Univ of Alabama-Huntsville
Pratt & Whitney
Northrop Grumman
Hamilton Sundstrand



### **JMQWG MASTER ACTION PLAN SCHEDULE**

Project/Event Name: JMQWG Organizer's Name: Mitch Kaarlela

This Master Action Plan now takes into account that we have proven the feasibility of posting the GEIA Matrix and Test Reports on the DAU website. Our next big hurdle is concluding our testing and writing the summaries & reports. Our objective is to conclude the JMQWG activities in the 2Q of CY 2006. Additional teleconferences can be inserted, if needed

PROJECT ACTION	STARTING	ENDING			
Telecon 3.2	01/11/2006	01/11/2006			
Companies Submit Test Parts & Coupons for Testing UA-H will Perform	01/16/2006	01/31/2006			
Companies and UA-H Perform IUID Marking Method Testing	02/01/2006	02/28/2006			
UID Forum, Seattle, WA	02/21/2006	02/22/2006			
Telecon 3.3	02/08/2006	02/08/2006			
Industry Translates Testing Performed into Test Data Summary Sheets	03/01/2006	03/31/2006			
Telecon 3.4	03/08/2006	03/08/2006			
Test Data Summary Sheets loaded into MS Access Database by UA-H	04/03/2006	04/14/2006			
UID Forum, Providence, RI	04/19/2006	04/20/2006			
Hotlinks to Database Posted on DAU ACC website	04/24/2006	04/26/2006			
Telecon 3.5	04/26/2006	04/26/2006			
JMQWG Main Activity Completed	04/28/2006	04/28/2006			
Post-JMQWG Review & Wrap-Up of all Activities and Web-Posted Info	05/15/2006	05/19/2006			
UID Forum, Dallas, TX	09/12/2006	09/13/2006			

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The Voice of the Industrial Base

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STREET SCOPENTING

# DAU Website $\rightarrow 1,541$ Total Hits as of 17 Apr 2006



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lense Acquisition Universit Acquisition Community Connection linious Mantfilmine (1870) Policy & Rel JMQWG Marking Qualification Data Program Manager Making C Contracting JHQWG Harfring Qualification Data A Joint Marking Qualification Working Group (JMQWG) has been estabished under the sponsorship of GEIA to coordinate a "consortium approach" towards performing, publishing and sharing non-proprietary 2D Data Matrix marking qualification test and report data. New TUID Harking Technology Edeas Limited access is available for CoPs & SIAs without login Industry Implementati Solution Providers To use this site most effectively, take the following actions, in order (page 1) Training Center (sup A) Read the Generic Marking Guide document Outlook for this Tee Search Conversation (Step 0) read the IUID Decision Tree Flowchart, and (Step 0) review the GEIA Marking Qualification Matrix. E-mail this Page PEOPLE If you perform marking qual testing, please take additional Hr. Deb Faller (Viewed 428 times) Community Facilit (see p) and prepare a Test Data Summary Sheet and share your summary data and detailed test report with Industry/Government. Hr. Jil Garcia (Viewed 518 it-Knowledge Hirz, Deborah Ad <u>ت</u> (Viewed 015 times) Hr. Nitch Kaariela ž. Example 1 - Test Data Summary Sheet (Viewed 7 times) Example 2 - Test Data Summary Sheet HOST VISITED (LAST 12 HOWTHS Example 3 - Qual Test Report GEA UID Initiative (JBOWG Announcement) (Viewer 470 Example 4 - Qual Test Data Sher New IUID Marking Technology Idea (Nawed 324 times) GEA UID Initia ved 480 times) Step C - GEIA Marking Qual Mairte (Updated 21 Jan 2005) (Viewed 221 times) (Viewed 480 times) wert 54 times JMOWG Naster Action Plan Schedule for CY 2005 Step A - Genetic Marking Guide (GenMark) Version 0.2 - DRAFT (Viewer) 101 (Street) JMQWG Nesting Notes & Charts Step B - IUID Decision Tre (Updated 20 Dec 2005) JMQ/WG Progress Announcement (01 Mar 2006) (Viewed 15 times) case studies Tech Survey - AlT and Tracking Technologies (Aug 2000) (Viewed 23 Smea Test Report - Aircraft Flight Critical Part Verification System (Jun 1993) (Viewed 47 times Test Report - AlT Marking Data on Multiple Materials (Aug 1992) (Viewed 47 Strest) Test Report - DPM Microscopy for Aging Landing Gear Life Extension Program (Jan 2004) (Viewed 3D times) est Report - DPM on Aging Landing Gear Life Extension Program (Jan 2004) (Viewed 24 times) ort - DPM Reader 2 on Aging Landing Gear Life Extension Program (Apr 2004) (Viewed 231 eet Report - DPM Reader on Aging Landing Gear Life Extension Program (Apr 2004) (Viewed 32 times) Test Report - DPM Survivability for Normal Landing Gear Part Overhaul Conditions (Jan 2004) (Viewed 3) Test Report - High Cycle Fatigue Test on Selected Materials (Dec 1993) (Viewed 1 Test Report - Imp DPH Microscopy (Mar 2000) (Viewed 25 times) Test Report - Imp DPM Microscopy for Aging Landing Gear Life Exten G. .

Over <u>1,000</u> Just Since mid-Jan 2006

NATIONAL DEFENSE INDUSTRIAL ASSOCIATION







est Report - Laser Marked TI-SAI-W (Sep 1992) (Viewed 26 times)

eet Report - Laser Marked Turtsine Blade (Sep 1992) (Viewed 24 time

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### **IMQWG Status Summary** Industry & Gov't Participation in JMQWG is Good Some Work Products Available Now! More Coming Over the Next 3-6 Months DoD Contracted With UA-H for 12 Month Support **Existing Data is Being Analyzed, Organized & Linked Will be Incrementally Posted to Web w/Parallel Peer Review** "Guidance Only" Deliverables (a "path" to testing....) Realizing DoD & Industry Association Support ✓ DAU Website is Working Well

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